

• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- BLDC Motor driver
- DC-DC
- Battery protection

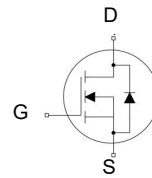
• Ordering Information:

| | |
|---------------------------|--------------|
| Part NO. | ZMSA011N04HR |
| Marking | ZMS011N04H |
| Packing Information | REEL TAPE |
| Basic ordering unit (pcs) | 2000 |

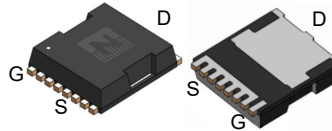
• Absolute Maximum Ratings ($T_C=25^\circ\text{C}$)

| Parameter | Symbol | Conditions | Value | Unit |
|----------------------------------|-----------|-------------------------------------------------------------------|-------------|------------------|
| Drain-Source Voltage | V_{DS} | | 40 | V |
| Gate-Source Voltage ^① | V_{GS} | | ± 20 | V |
| Continuous Drain Current | I_D | $T_C=25^\circ\text{C}$ | 160 | A |
| | I_D | $T_C=75^\circ\text{C}$ | 160 | A |
| | I_D | $T_C=100^\circ\text{C}$ | 160 | A |
| Pulsed Drain Current | I_{DM} | Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^\circ\text{C}$; | 480 | A |
| Total Power Dissipation | P_D | $T_C=25^\circ\text{C}$ | 300 | W |
| Total Power Dissipation | P_D | $T_A=25^\circ\text{C}$ | 5.0 | W |
| Operating Junction Temperature | T_J | | -55 to +175 | $^\circ\text{C}$ |
| Storage Temperature | T_{STG} | | -55 to +175 | $^\circ\text{C}$ |
| Single Pulse Avalanche Energy | E_{AS} | $L=0.1\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$, | 320 | mJ |
| | | $L=0.5\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$, | 736 | mJ |
| ESD Level (HBM) | CLASS 2 | | | |

• Product Summary



$V_{DS} = 40\text{V}$
 $R_{DS(ON)} = 1.3\text{m}\Omega$
 $I_D = 160\text{A}$



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•Thermal resistance

| Parameter | Symbol | Min. | Typ. | Max. | Unit |
|--------------------------------------|----------------|------|------|------|------|
| Thermal resistance, junction - case | R_{thJC} | | - | 0.5 | °C/W |
| Thermal resistance, junction-ambient | $R_{thJA}^{②}$ | | - | 30 | °C/W |
| Soldering temperature | Tsold | | - | 260 | °C |

•Electronic Characteristics

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
|-----------------------------------|--------------|-------------------------------|------|------|------|------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0V, I_D=250\mu A$ | 40 | | | V |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{GS}=V_{DS}, I_D=250\mu A$ | 2.0 | 2.7 | 4.0 | V |
| Drain-Source Leakage Current | I_{DSS} | $V_{GS}=0V, V_{DS}=40V$ | | | 1.0 | uA |
| Gate- Source Leakage Current | I_{GSS} | $V_{GS}=\pm 20V, V_{DS}=0V$ | | | 100 | nA |
| Static Drain-source On Resistance | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=30A$ | | 1.3 | 1.6 | mΩ |
| Forward Transconductance | g_{FS} | $V_{DS}=5V, I_{SD}=20A$ | | 28 | | s |
| Diode Forward Voltage | V_{FSD} | $V_{GS}=0V, I_{SD}=30A$ | | | 1.3 | V |

•Dynamic characteristics

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
|------------------------------|--------------|--------------------------------------------------|------|------|------|------|
| Input capacitance | C_{iss} | $f = 1MHz, V_{DS}=25V$ | - | 5430 | - | pF |
| Output capacitance | C_{oss} | | - | 1520 | - | |
| Reverse transfer capacitance | C_{rss} | | - | 84 | - | |
| Gate Resistance | R_g | $f = 1MHz$ | - | 1.6 | | Ω |
| Total gate charge | Q_g | $V_{DD}=15V, I_D=20A, V_{GS}=10V$ | - | 87 | - | nC |
| Gate - Source charge | Q_{gs} | | - | 21 | - | |
| Gate - Drain charge | Q_{gd} | | - | 19 | - | |
| Turn-ON Delay time | $t_{D(on)}$ | $V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=20A$ | - | 15 | - | ns |
| Turn-ON Rise time | t_r | | - | 10 | - | ns |
| Turn-Off Delay time | $t_{D(off)}$ | | - | 26 | - | ns |
| Turn-Off Fall time | t_f | | - | 17 | - | ns |
| Reverse Recovery Time | t_{RR} | $V_{DD}=20V, dI_S/dt = 100A/\mu s, I_S=50A$ | - | 65 | - | ns |
| Reverse Recovery Charge | Q_{RR} | | - | 95 | - | nC |

Fig.1 Gate-Charge Characteristics

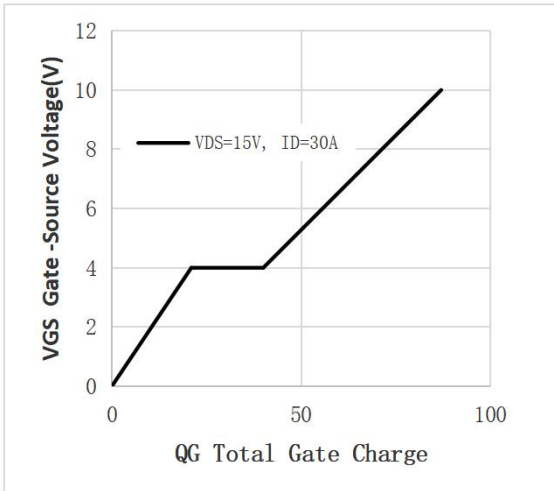


Fig.2 Capacitance Characteristics

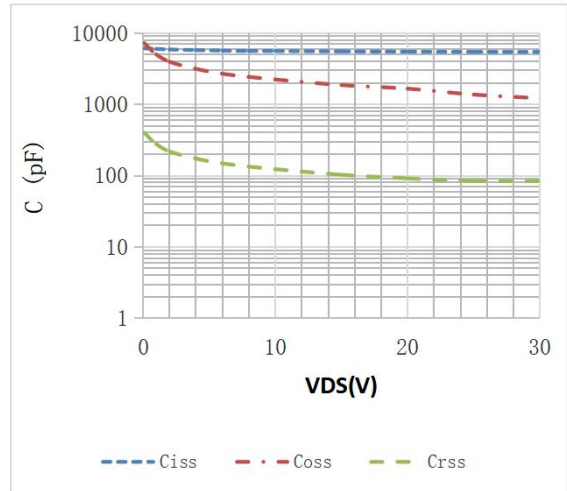


Fig.3 Power Dissipation

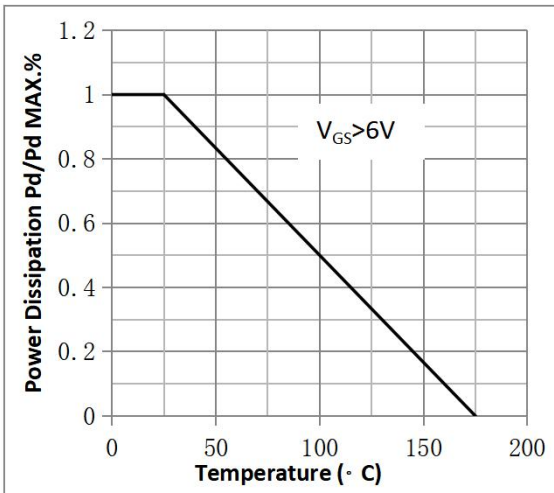


Fig.4 Typical output Characteristics

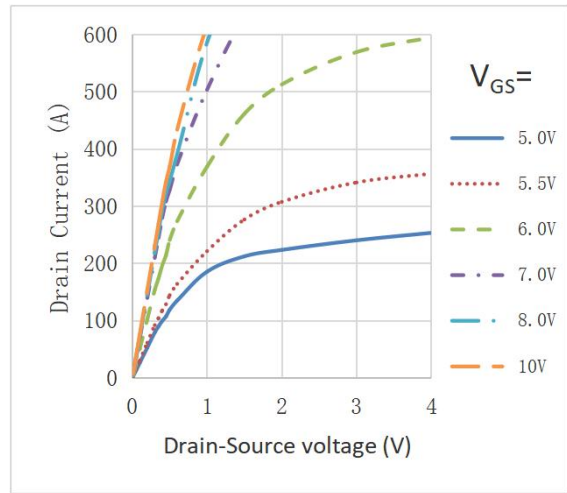


Fig.5 Threshold Voltage V.S Junction Temperature

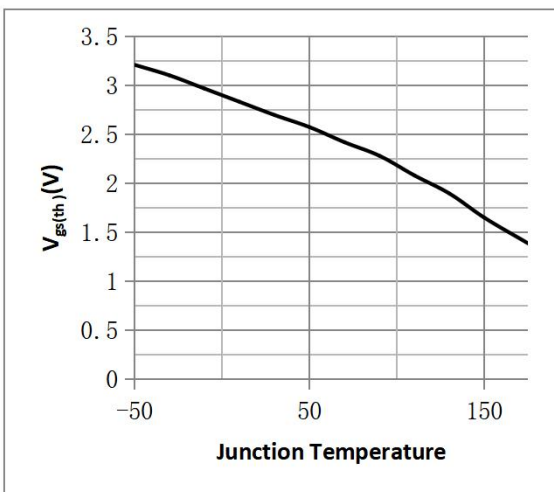


Fig.6 Resistance V.S Drain Current

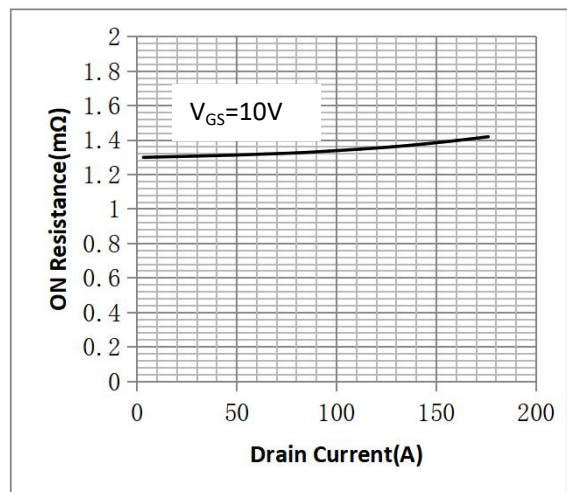


Fig.7 On-Resistance VS Gate Source Voltage

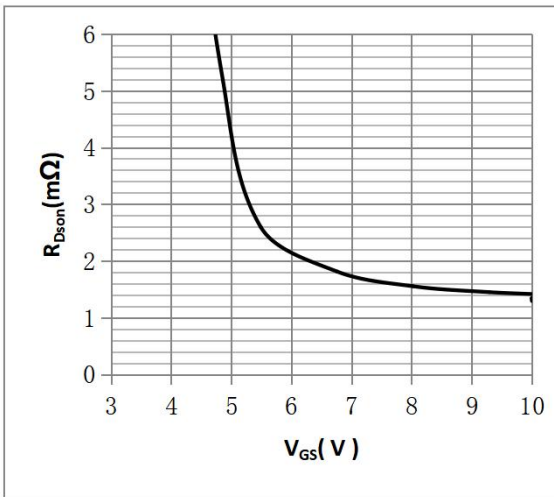


Fig.8 On-Resistance V.S Junction Temperature

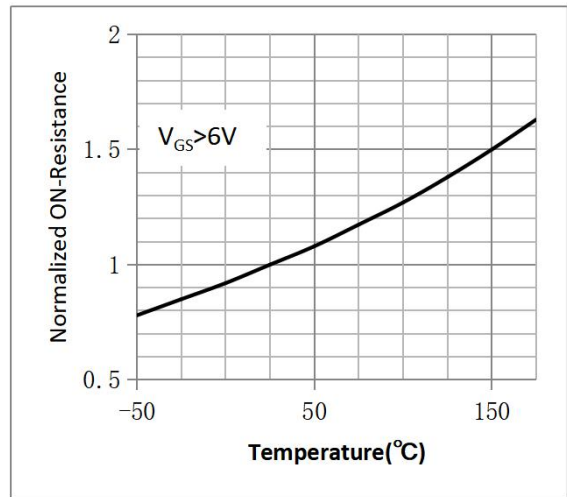


Figure 9. Diode Forward Voltage vs. Current

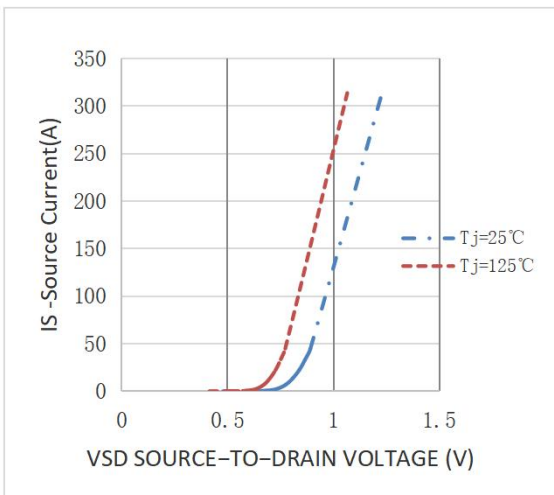


Figure 10. Transfer Characteristics

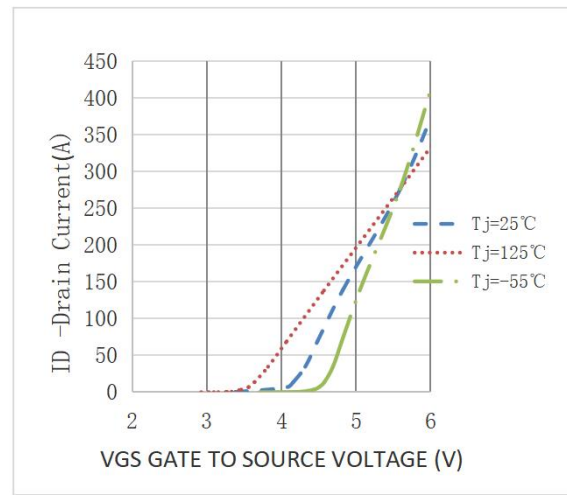


Fig.11 Safe Operating Area

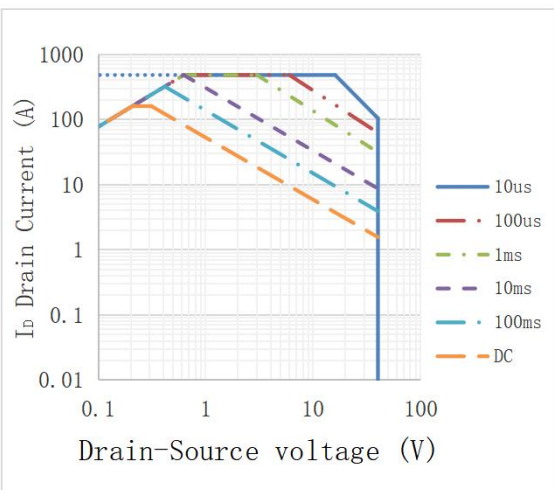
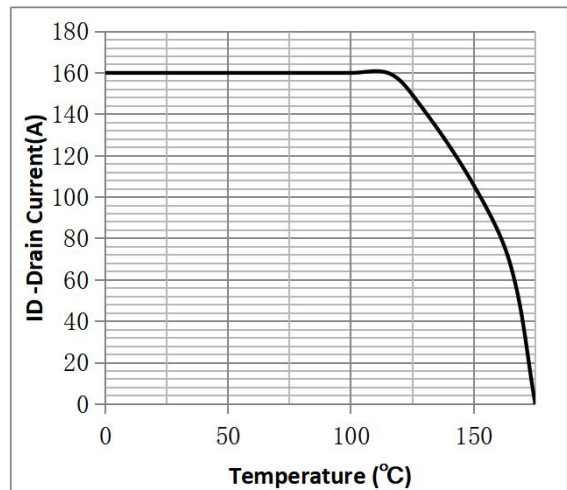
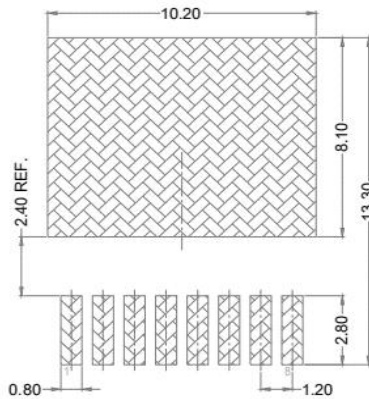
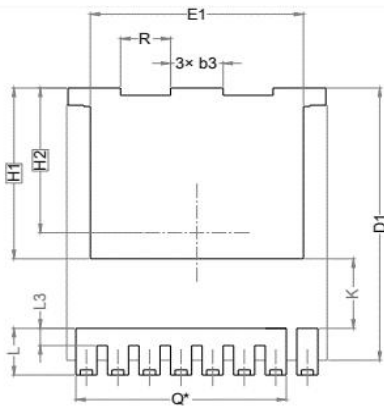
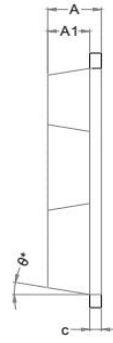
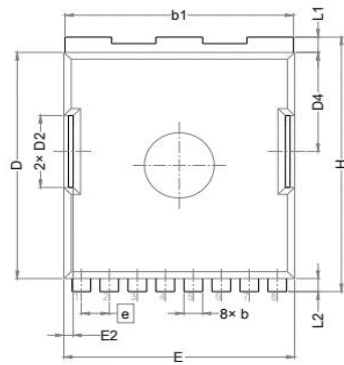


Fig.12 ID vs. Junction Temperature^③



•TOLL Package Outline



| SYMBOL | DIMENSIONS | | |
|--------|------------|-------|-------|
| | MIN. | NOM. | MAX. |
| A | 2.20 | 2.30 | 2.40 |
| A1 | 1.70 | 1.80 | 1.90 |
| b | 0.70 | 0.80 | 0.90 |
| b1 | 9.70 | 9.80 | 9.90 |
| b3 | 1.90 | 2.00 | 2.10 |
| c | 0.40 | 0.50 | 0.60 |
| D | 10.28 | 10.38 | 10.48 |
| D1 | 10.98 | 11.08 | 11.18 |
| D2 | 3.20 | 3.30 | 3.40 |
| D4 | 4.45 | 4.55 | 4.65 |
| E | 9.80 | 9.90 | 10.00 |
| E1 | 8.00 | 8.10 | 8.20 |
| E2 | 0.30 | 0.40 | 0.50 |
| e | 1.20 BSC | | |
| H | 11.58 | 11.68 | 11.78 |
| H1 | 6.95 BSC | | |
| H2 | 5.89 BSC | | |
| i | 0.10 REF. | | |
| j | 0.46 REF. | | |
| K | 2.80 REF. | | |
| L | 1.60 | 1.90 | 2.10 |
| L1 | 0.60 | 0.70 | 0.80 |
| L2 | 0.50 | 0.60 | 0.70 |
| L3 | 0.60 | 0.70 | 0.80 |
| N | 8 | | |
| Q | 6.80 REF. | | |
| R | 1.80 | 1.90 | 2.00 |
| θ | 10° REF. | | |

Note:

- ① Pulse : $V_{GS}=+20V/-20V$, Duty cycle=50%, $T_j=175^{\circ}C$, $t=1000$ hours; For DC , the following test conditions can be passed: $V_{GS}=+20V/-10V$, $T_j=175^{\circ}C$, $t=1000$ hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS}=10V$.

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Revision History

| Version | Date | Change |
|---------|------------|-------------------------------------|
| A | 2021.9.6 | |
| B | 2022.9.5 | 1.Add Reach, HF figure, 2.ID modify |
| C | 2022.12.6 | ID and ID curve modify |
| D | 2023.12.28 | Correct SOA, Rdson |
| | | |
| | | |
| | | |
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